

Search Notes

Application/Control No.

10/707,749

Examiner

Y. J. Han

Applicant(s)/Patent under
Reexamination

FUNG ET AL.

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
363	16		
	17		
	21.01- 21.18		
	24		
	25		
	37		
	97		
	131	9/05	JK
See search report 9/05 JK			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS	9/05	JK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner